



STS8C5H30L

N-channel 30V - 0.018 Ω - 8A/P-channel 30V - 0.045 Ω - 5A - SO-8
Low gate charge STripFET™ III MOSFET

General features

Type	V _{DSS}	R _{DS(on)}	I _D
STS8C5H30L(N-channel)	30V	<0.022	8A
STS8C5H30L(P-channel)	30V	<0.056	5A

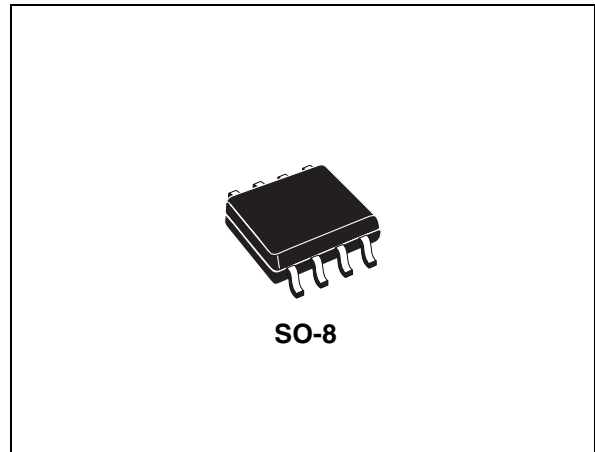
- Conduction losses reduced
- Switching losses reduced
- Low threshold drive
- Standard outline for easy automated surface mount assembly

Description

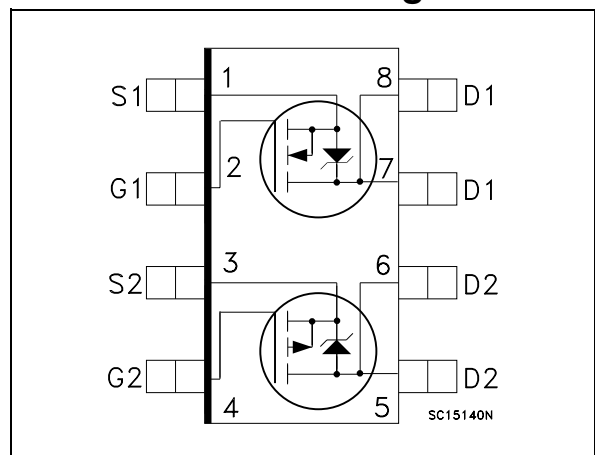
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

- Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STS8C5H30L	S8C5H30L	SO-8	Tape & reel

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value		Unit
		N-channel	P-channel	
V_{DS}	Drain-source voltage ($v_{gs} = 0$)	30		V
V_{GS}	Gate- source voltage	± 16	± 16	V
I_D	Drain current (continuous) at $T_C = 25^\circ\text{C}$ single operating	8	4.2	A
I_D	Drain current (continuous) at $T_C = 100^\circ\text{C}$ single operating	6.4	3.1	A
$I_{DM}^{(1)}$	Drain current (pulsed)	32	16.8	A
P_{TOT}	Total dissipation at $T_C = 25^\circ\text{C}$ dual operating	1.6		W
	Total dissipation at $T_C = 25^\circ\text{C}$ single operating	2		W
T_{stg}	Storage temperature	-55 to 150		$^\circ\text{C}$
T_j	Operating junction temperature	150		$^\circ\text{C}$

1. Pulse width limited by safe operating area

For the P-channel MOSFET actual polarity of voltages and current has to be reversed

Table 2. Thermal data

R_{thj-a}	Thermal resistance junction-ambient single operating	62.5	$^\circ\text{C/W}$
	Thermal resistance junction-ambient dual operating	78	$^\circ\text{C/W}$
T_l	Maximum lead temperature for soldering purpose	300	$^\circ\text{C}$

2 Electrical characteristics

($T_{CASE}=25^{\circ}\text{C}$ unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown voltage	$I_D = 250\ \mu\text{A}$, $V_{GS} = 0$	n-ch p-ch	30 30			V V
I_{DSS}	Zero gate voltage Drain current ($V_{GS} = 0$)	$V_{DS} = \text{Max rating}$ $V_{DS} = \text{Max rating}$, $T_C = 125^{\circ}\text{C}$	n-ch p-ch			1 10	μA μA
I_{GSS}	Gate-body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 16\text{V}$ $V_{GS} = \pm 16\text{V}$	n-ch p-ch			± 100 ± 100	nA nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$	n-ch p-ch	1 1	1.6	2.5	V V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10\text{V}$, $I_D = 4\text{A}$ $V_{GS} = 10\text{V}$, $I_D = 2.5\text{A}$ $V_{GS} = 4.5\text{V}$, $I_D = 4\text{A}$ $V_{GS} = 4.5\text{V}$, $I_D = 2.5\text{A}$	n-ch p-ch n-ch p-ch		0.018 0.045 0.020 0.070	0.022 0.055 0.025 0.075	Ω Ω Ω Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} = 15\text{V}$, $I_D = 4\text{A}$ $V_{DS} = 15\text{V}$, $I_D = 2.5\text{A}$	n-ch p-ch		8.5 10		S S
C_{iss}	Input capacitance		n-ch p-ch		857 1350		pF pF
C_{oss}	Output capacitance	$V_{DS} = 25\text{V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$	n-ch p-ch		147 490		pF pF
C_{rss}	Reverse transfer capacitance		n-ch p-ch		20 130		pF pF
Q_g	Total gate charge	N-channel $V_{DD} = 24\text{V}$ $I_D = 8\text{A}$ $V_{GS} = 5\text{V}$	n-ch p-ch		7 12.5	10 16	nC nC
Q_{gs}	Gate-source charge	P-channel $V_{DD} = 24\text{V}$ $I_D = 4\text{A}$ $V_{GS} = 5\text{V}$	n-ch p-ch		2.5 5		nC nC
Q_{gd}	Gate-drain charge	(see Figure 26)	n-ch p-ch		2.3 3		nC nC

1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5.

Table 5. Switching times

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time	N-channel $V_{DD} = 15V, I_D = 4A$ $R_G = 4.7 \Omega, V_{GS} = 4.5V$	n-ch		12		ns
			p-ch		25		ns
	Rise time	P-channel $V_{DD} = 15V, I_D = 2A$ $R_G = 4.7 \Omega, V_{GS} = 4.5V$ (see Figure 25)	n-ch		14.5		ns
			p-ch		35		ns
$t_{d(off)}$ t_f	Turn-off delay time	N-channel $V_{DD} = 15V, I_D = 4A$ $R_G = 4.7 \Omega, V_{GS} = 4.5V$	n-ch		23		ns
			p-ch		125		ns
	Fall time	P-channel $V_{DD} = 15V, I_D = 2A$ $R_G = 4.7 \Omega, V_{GS} = 4.5V$ (see Figure 25)	n-ch		8		ns
			p-ch		35		ns

Table 6. Source drain diode

Symbol	Parameter	Test conditions		Min	Typ.	Max	Unit
I_{SD}	Source-drain current		n-ch			8	A
			p-ch			5	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		n-ch			32	A
			p-ch			20	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 8A, V_{GS} = 0$	n-ch			1.5	V
		$I_{SD} = 5A, V_{GS} = 0$	p-ch			1.2	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	N-channel $I_{SD} = 8A, di/dt = 100A/\mu s$ $V_{DD}=15\text{ V}, T_j = 150\text{ }^{\circ}C$ P-channel $I_{SD} = 5\text{ A}, di/dt = 100A/\mu s$ $V_{DD}=15\text{ V}, T_j = 150\text{ }^{\circ}C$ (see Figure 27)	n-ch		15		ns
			p-ch		45		ns
			n-ch		5.7		nC
			p-ch		36		nC
			n-ch		0.76		A
			p-ch		1.6		A

1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area n-ch

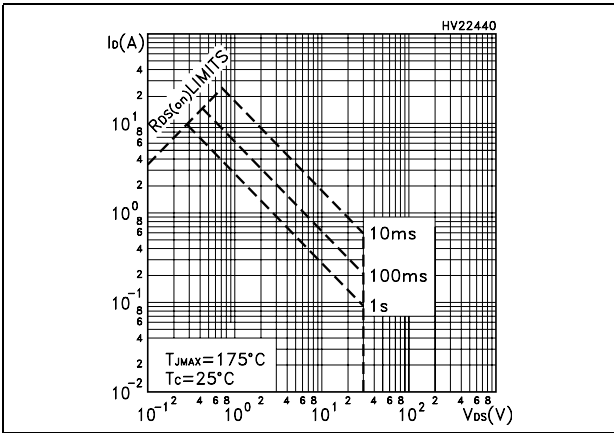


Figure 2. Thermal impedance n-ch

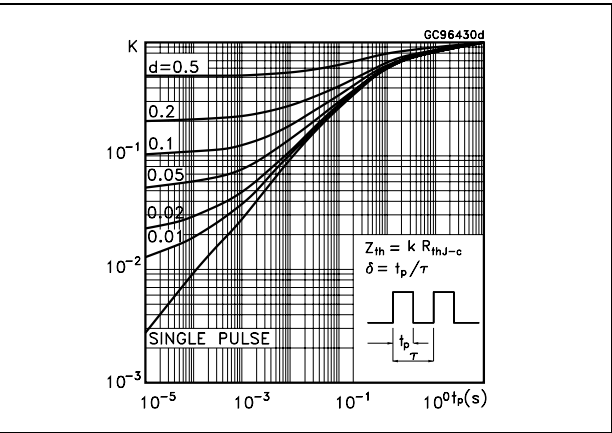


Figure 3. Output characteristics n-ch

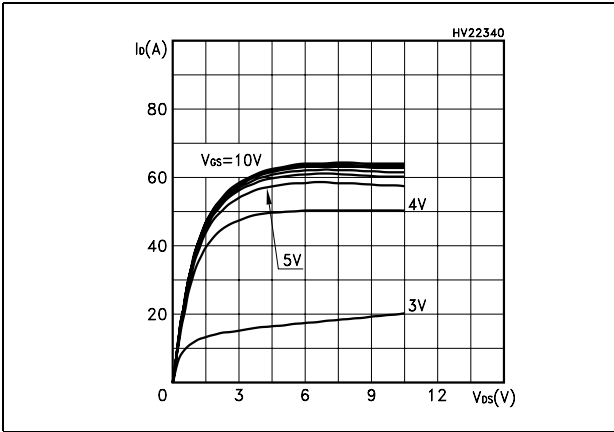


Figure 4. Transfer characteristics n-ch

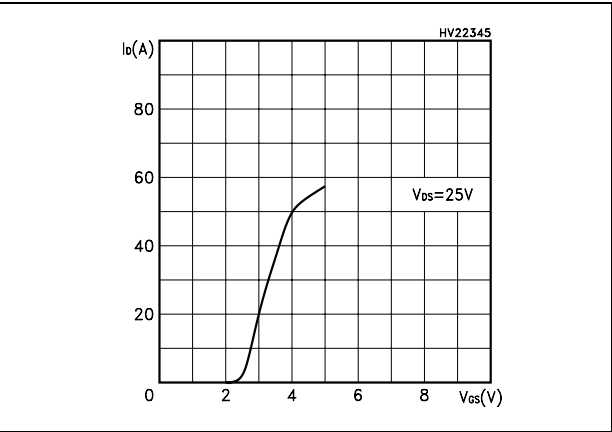


Figure 5. Transconductance n-ch

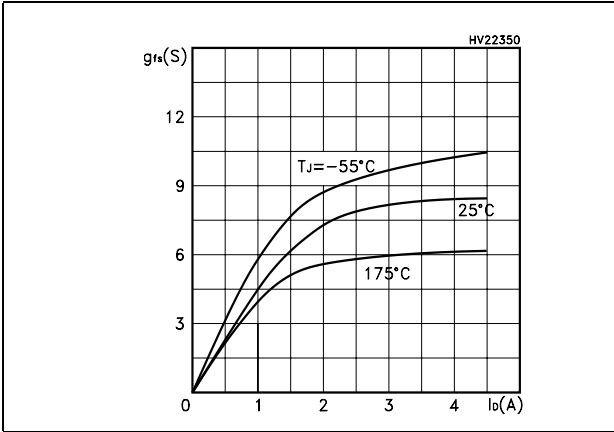


Figure 6. Static drain-source on resistance n-ch

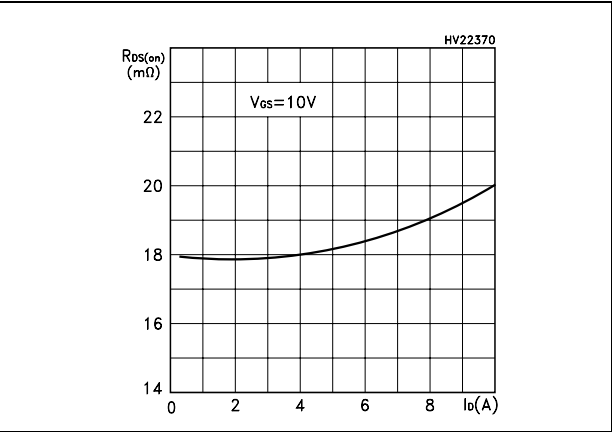


Figure 7. Gate charge vs. gate-source voltage n-ch
Figure 8. Capacitance variations n-ch

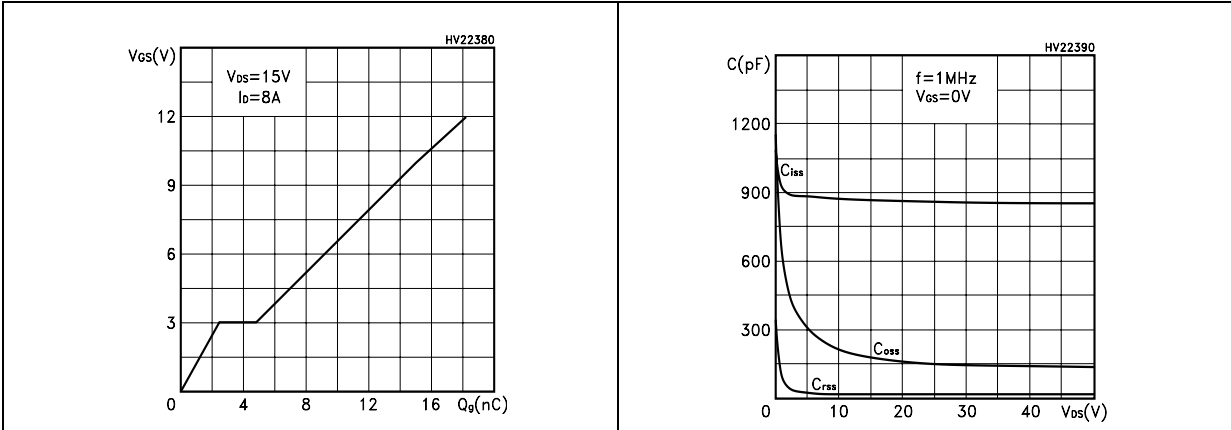


Figure 9. Normalized gate threshold voltage vs. temperature n-ch
Figure 10. Normalized on resistance vs. temperature n-ch

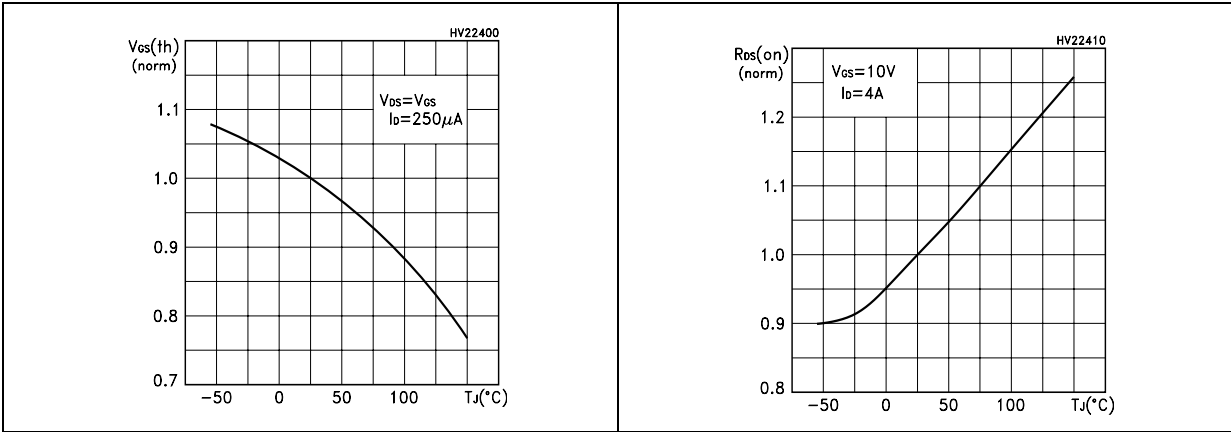


Figure 11. Source-drain diode forward characteristics n-ch
Figure 12. Normalized breakdown voltage vs. temperature n-ch

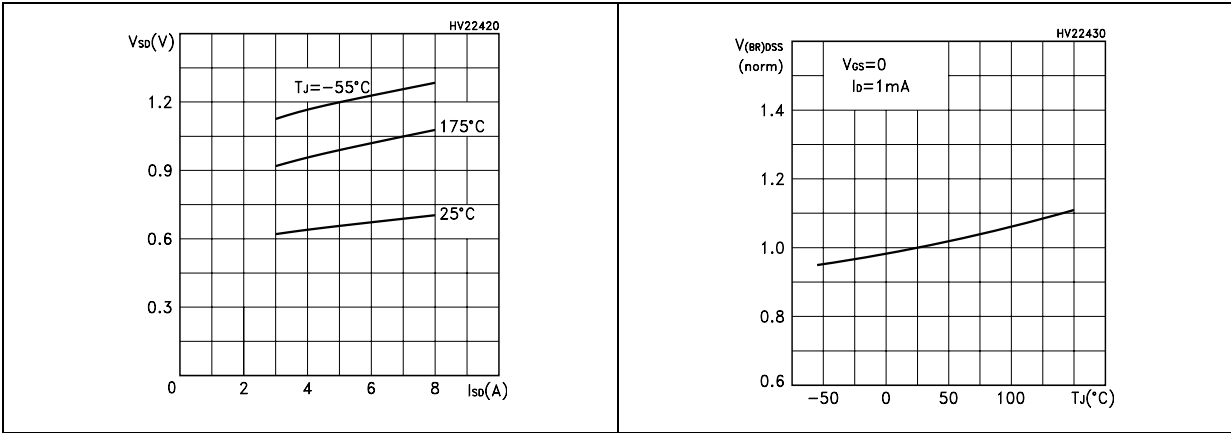


Figure 13. Safe operating area p-ch

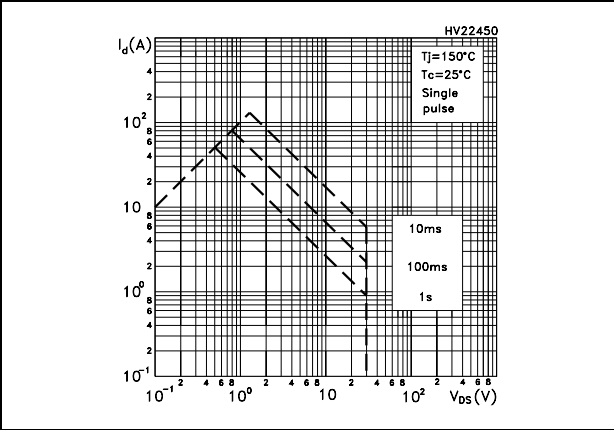


Figure 14. Thermal impedance p-ch

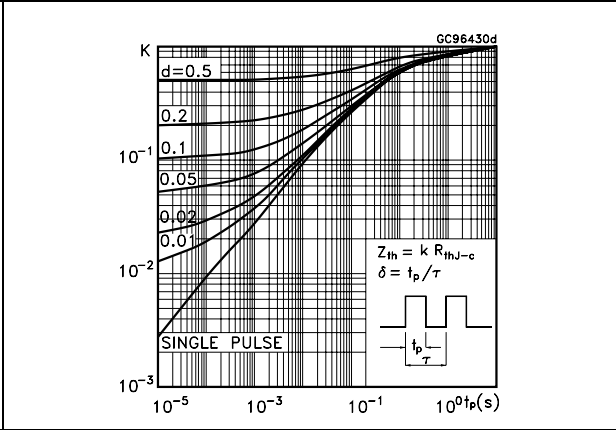


Figure 15. Output characteristics p-ch

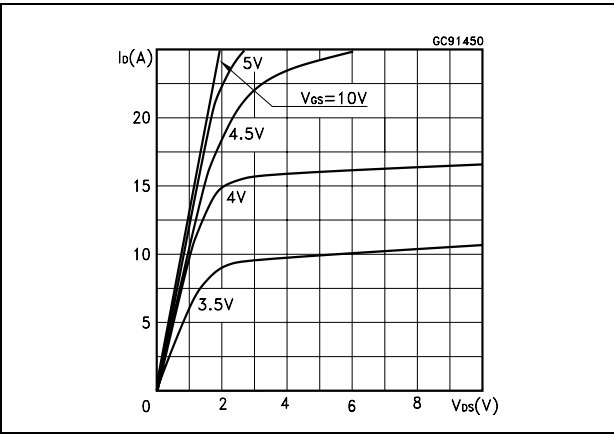


Figure 16. Transfer characteristics p-ch

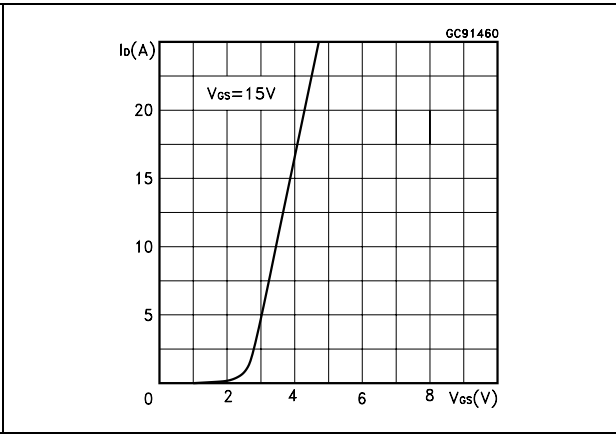


Figure 17. Transconductance p-ch

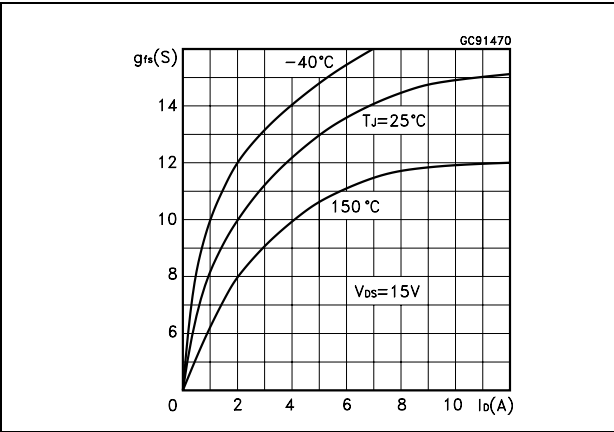


Figure 18. Static drain-source on resistance p-ch

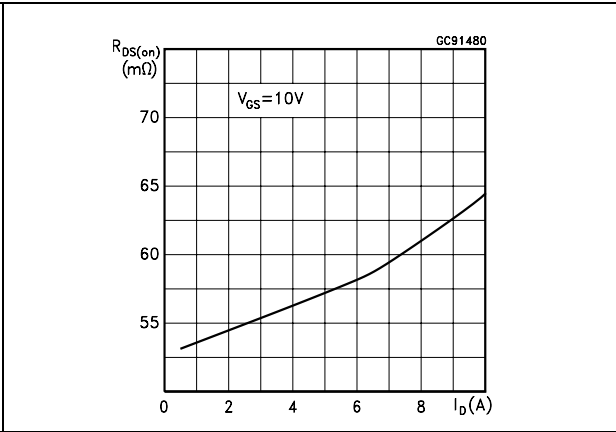


Figure 19. Gate charge vs. gate-source voltage p-ch

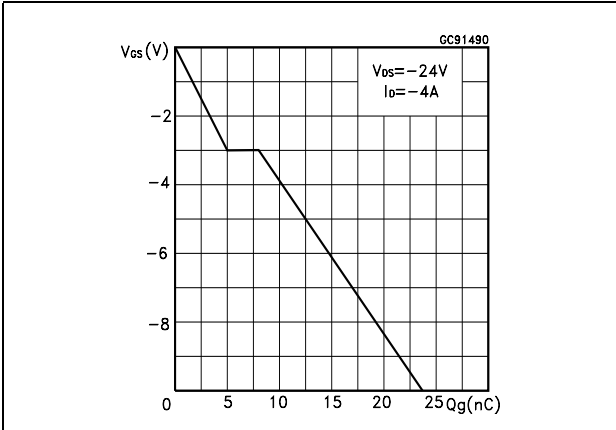


Figure 20. Capacitance variations p-ch

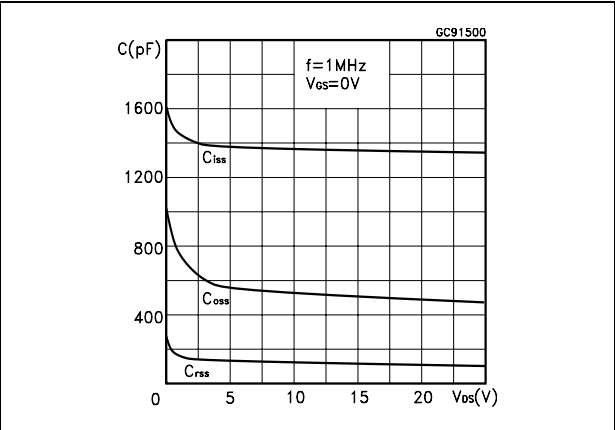


Figure 21. Normalized gate threshold voltage vs. temperature p-ch

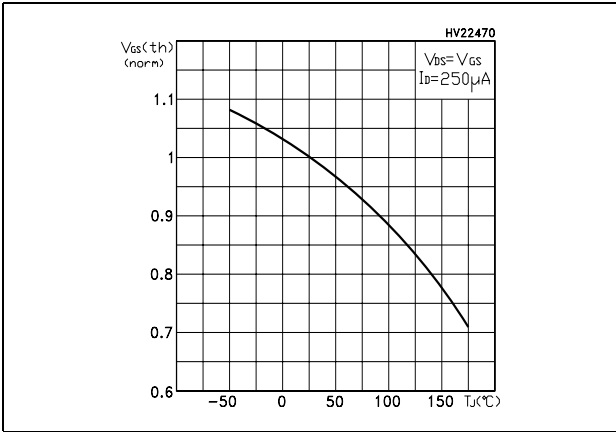


Figure 22. Normalized on resistance vs. temperature p-ch

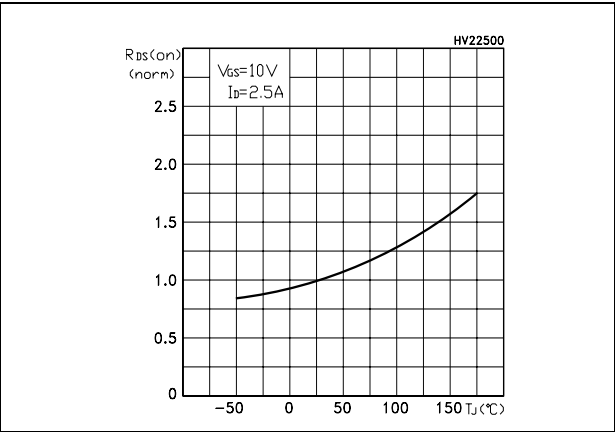


Figure 23. Source-drain diode forward characteristics p-ch

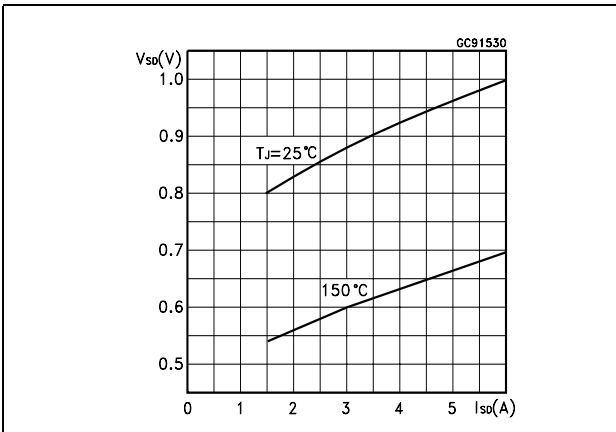
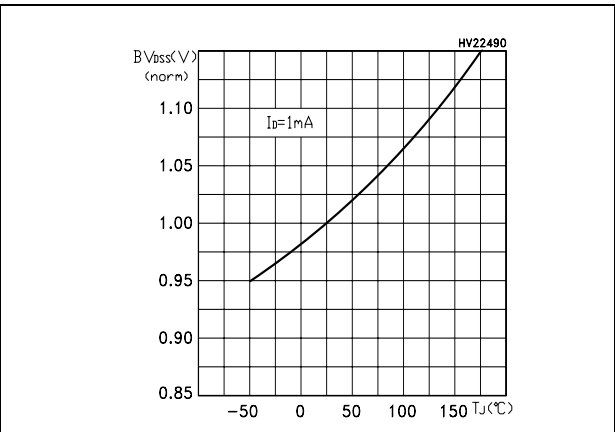


Figure 24. Normalized breakdown voltage vs. temperature p-ch



3 Test circuit

Figure 25. Switching times test circuit for resistive load

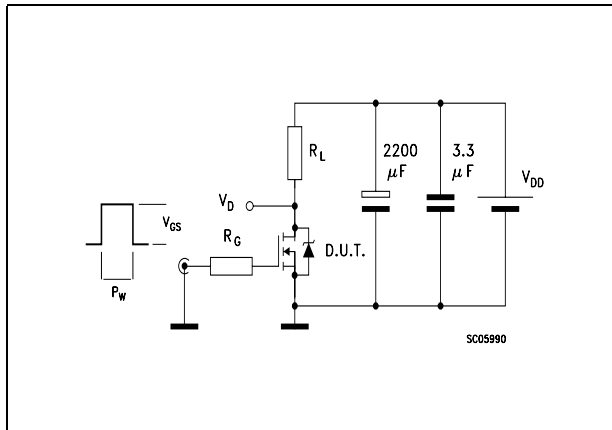


Figure 26. Gate charge test circuit

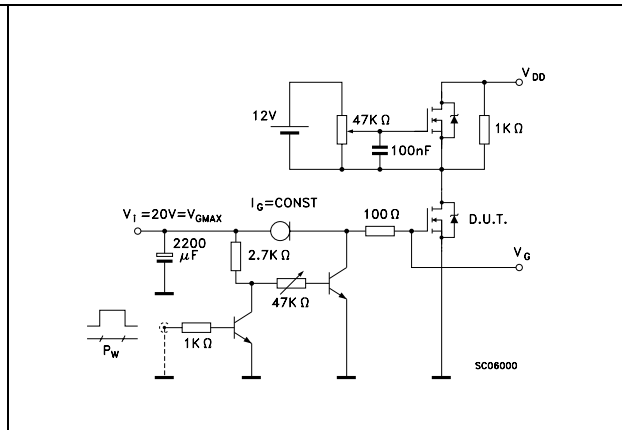


Figure 27. Test circuit for inductive load switching and diode recovery times

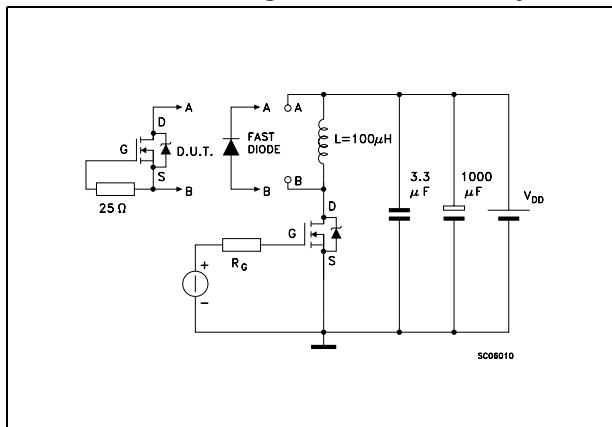


Figure 28. Unclamped Inductive load test circuit

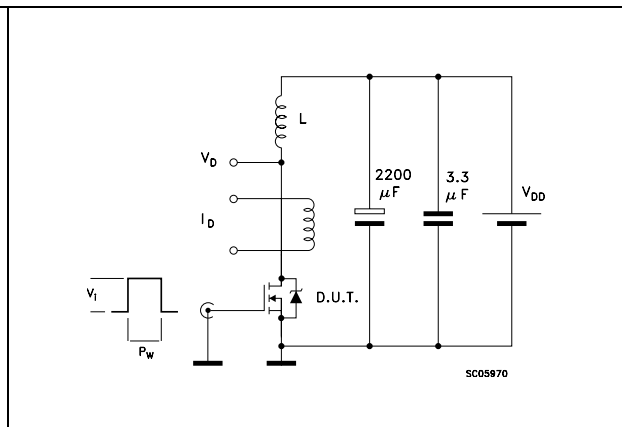


Figure 29. Unclamped inductive waveform

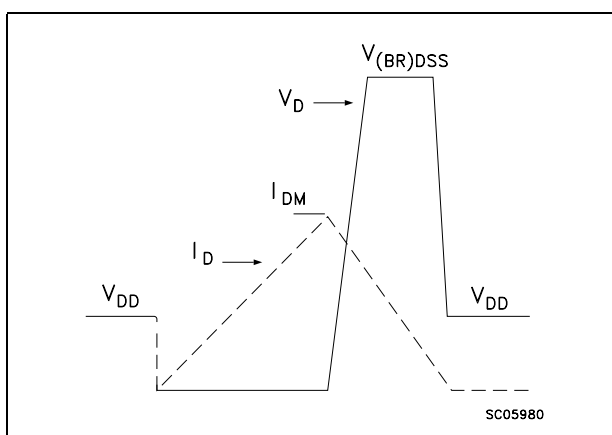
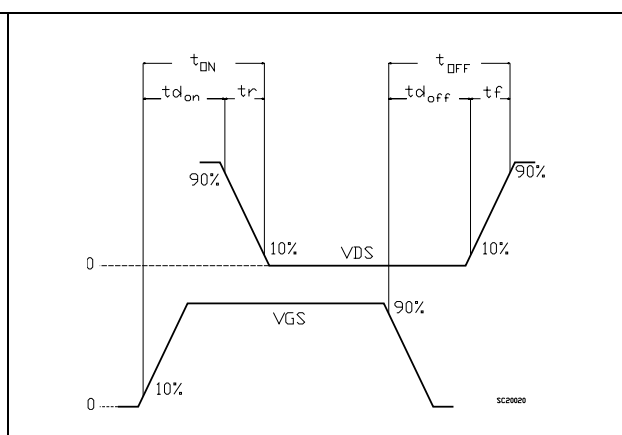


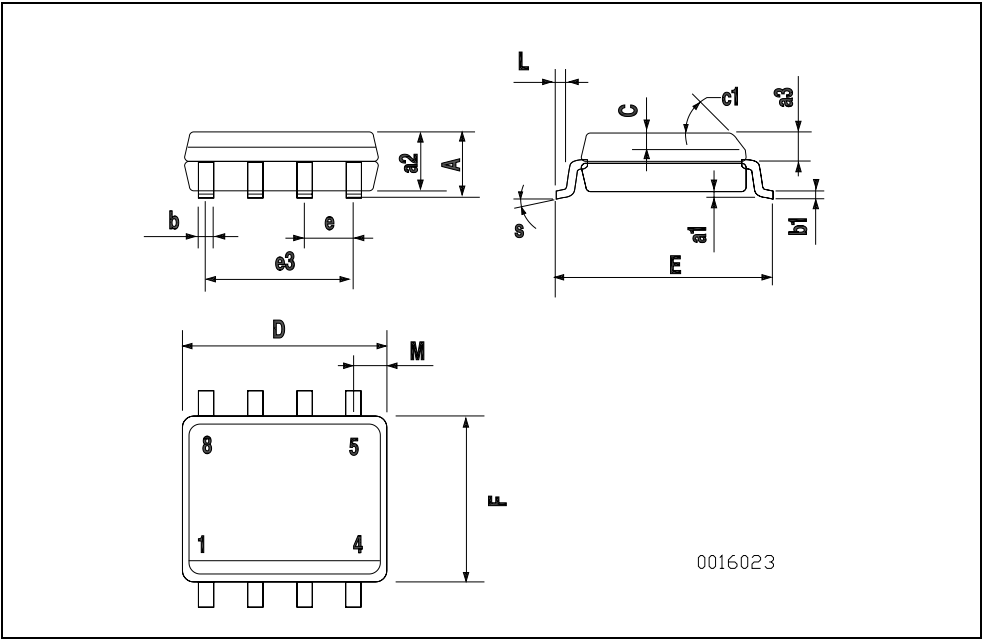
Figure 30. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at : www.st.com

SO-8 MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S	8 (max.)					



5 Revision history

Table 7. Revision history

Date	Revision	Changes
17-Sep-2004	1	First revision
31-Oct-2006	2	The document has been reformatted
30-Jan-2007	3	typo mistake on Table 1 .

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